## FEATURES

## 4-wire touch screen interface

1.6 V to 3.6 V operation

Median and averaging filter to reduce noise
Automatic conversion sequencer and timer
User-programmable conversion parameters
Auxiliary analog input/battery monitor ( 0.5 V to 5 V )
1 optional GPIO
Interrupt outputs ( $\overline{\text { INT }}, \overline{\text { PENIRQ }})$
Touch-pressure measurement
Wake-up on touch function
Shutdown mode: $6 \mu \mathrm{~A}$ maximum
12-ball, $1.6 \mathrm{~mm} \times 2 \mathrm{~mm}$ WLCSP
16-lead, $4 \mathrm{~mm} \times 4 \mathrm{~mm}$ LFCSP

## APPLICATIONS

## Personal digital assistants

Smart hand-held devices
Touch screen monitors
Point-of-sale terminals
Medical devices
Cell phones

## GENERAL DESCRIPTION

The AD7879 is a 12-bit successive approximation analog-todigital converter (ADC) with a synchronous serial interface and low on-resistance switches for driving 4-wire resistive touch screens. The AD7879 works with a very low power supply (a single 1.6 V to 3.6 V ) and features throughput rates of 105 kSPS .

The device includes a shutdown mode that reduces its current consumption to less than $6 \mu \mathrm{~A}$.
To reduce the effects of noise from LCDs and other sources, the AD7879 contains a preprocessing block. The preprocessing function consists of a median and an averaging filter. The combination of these two techniques provides a more robust solution, discarding the spurious noise in the signal and keeping only the data of interest. The size of both filters is programmable. Other user-programmable conversion controls include variable acquisition time and first conversion delay; up to 16 averages can be taken per conversion. The AD7879 can run in either slave or standalone mode, using an automatic conversion sequencer and timer.


The AD7879 has a programmable pin that can operate as an auxiliary input to the ADC, as a battery monitor, or as a GPIO. There is also a programmable interrupt output that can operate in three modes: as a general-purpose interrupt to signal when new data is available INT, as an interrupt to indicate when limits are exceeded, or as a pen-down interrupt when the screen is touched (PENIRQ). The AD7879 offers temperature measurement and touch-pressure measurement.

The AD7879 is available in a 12 -ball, $1.6 \mathrm{~mm} \times 2 \mathrm{~mm}$ WLCSP and in a 16 -lead, $4 \mathrm{~mm} \times 4 \mathrm{~mm}$ LFCSP. The part also has either an SPI (AD7879) or I ${ }^{2} \mathrm{C}$ (AD7879-1) interface.

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## AD7879

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## REVISION HISTORY

## 10/08-Revision 0: Initial Version

## SPECIFICATIONS

$\mathrm{V}_{\mathrm{CC}}=1.6 \mathrm{~V}$ to $3.6 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$, unless otherwise noted.
Table 1.

| Parameter | Min | Typ | Max | Unit | Test Conditions/Comments |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DC ACCURACY |  |  |  |  |  |
| Resolution | 12 |  |  | Bits |  |
| No Missing Codes | 11 | 12 |  | Bits |  |
| Integral Nonlinearity (INL) ${ }^{1}$ |  |  | $\pm 3$ | LSB | LSB size $=390 \mu \mathrm{~V}$ |
| Differential Nonlinearity (DNL) ${ }^{1}$ |  |  |  |  | LSB size $=390 \mu \mathrm{~V}$ |
| Negative DNL |  |  | -0.99 | LSB |  |
| Positive DNL |  |  | +2 | LSB |  |
| Offset Error ${ }^{2}$ |  | $\pm 2$ | $\pm 6$ | LSB |  |
| Gain Error ${ }^{2}$ |  |  | $\pm 4$ | LSB |  |
| Noise ${ }^{3}$ |  | 70 |  | $\mu \mathrm{V}$ rms |  |
| Power Supply Rejection ${ }^{3}$ |  | 60 |  | dB |  |
| Internal Clock Frequency |  | 2 |  | MHz |  |
| SWITCH DRIVERS |  |  |  |  |  |
| On Resistance ${ }^{1}$ |  |  |  |  |  |
| Y + , $\mathrm{C}+$ |  | 6 |  | $\Omega$ |  |
| $\mathrm{Y}-\mathrm{X}-$ |  | 5 |  | $\Omega$ |  |
| ANALOG INPUTS |  |  |  |  |  |
| Input Voltage Ranges | 0 |  | $\mathrm{V}_{\text {cc }}$ | V |  |
| DC Leakage Current |  | $\pm 0.1$ |  | $\mu \mathrm{A}$ |  |
| Input Capacitance |  | 30 |  | pF |  |
| Accuracy |  | 0.3 |  | \% |  |
| TEMPERATURE MEASUREMENT |  |  |  |  |  |
| Temperature Range | -40 |  | +85 | ${ }^{\circ} \mathrm{C}$ |  |
| Resolution |  | 0.3 |  | ${ }^{\circ} \mathrm{C}$ |  |
| Accuracy ${ }^{2}$ |  | $\pm 2$ |  | ${ }^{\circ} \mathrm{C}$ | Calibrated at $25^{\circ} \mathrm{C}$ |
| BATTERY MONITOR |  |  |  |  |  |
| Input Voltage Range | 0 |  | 5 | V |  |
| Input Impedance ${ }^{3}$ |  | 16 |  | $\mathrm{k} \Omega$ |  |
| Accuracy |  | 2 | 5 | \% | Uncalibrated accuracy |
| LOGIC INPUTS (DIN, SCL, $\overline{C S}$, SDA, GPIO) |  |  |  |  |  |
| Input High Voltage, $\mathrm{V}_{\text {INH }}$ | 0.7 V cc |  |  |  |  |
| Input Low Voltage, $\mathrm{V}_{\text {INL }}$ |  |  | 0.3 V cc | V |  |
| Input Current, In |  | 0.01 |  | $\mu \mathrm{A}$ | $\mathrm{V}_{\mathrm{IN}}=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}$ |
| Input Capacitance, $\mathrm{CiN}^{3}$ |  | 10 |  | pF |  |
| LOGIC OUTPUTS (DOUT, GPIO, SCL, SDA, $\overline{\mathrm{INT}}$ ) |  |  |  |  |  |
| Output High Voltage, $\mathrm{V}_{\mathrm{OH}}$ | $V_{\text {cc }}-0.2$ |  |  | V |  |
| Output Low Voltage, VoL |  |  | 0.4 | V |  |
| Floating-State Leakage Current |  | $\pm 0.1$ |  | $\mu \mathrm{A}$ |  |
| Floating-State Output Capacitance ${ }^{2}$ |  | 5 |  | pF |  |
| CONVERSION RATE ${ }^{3}$ |  |  |  |  |  |
| Conversion Time |  | 9.5 |  | $\mu \mathrm{S}$ | Including $2 \mu$ s of acquisition time |
| Throughput Rate |  | 105 |  | kSPS |  |
| POWER REQUIREMENTS |  |  |  |  |  |
| $V_{\text {cc }}$ (Specified Performance) | 1.6 | 2.6 | 3.6 | V |  |
| Icc |  |  |  |  | Digital inputs $=0 \mathrm{~V}$ or $\mathrm{V}_{\text {cc }}$ |
| Converting Mode |  | 480 | 650 | $\mu \mathrm{A}$ | ADC on, $\mathrm{PM}=10$ |
| Static |  | 406 |  | $\mu \mathrm{A}$ | ADC and temperature sensor are off; the reference and oscillator are on; $\mathrm{PM}=01,11$ |
| Shutdown Mode |  | 0.5 | 6 | $\mu \mathrm{A}$ | $\mathrm{PM}=00$ |

[^0]
## AD7879

## SPI TIMING SPECIFICATIONS (AD7879)

$\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C} ; \mathrm{V}_{\mathrm{CC}}=1.6 \mathrm{~V}$ to 3.6 V , unless otherwise noted. Sample tested at $25^{\circ} \mathrm{C}$ to ensure compliance. All input signals are specified with $\mathrm{t}_{\mathrm{R}}=\mathrm{t}_{\mathrm{F}}=5 \mathrm{~ns}\left(10 \%\right.$ to $90 \%$ of $\left.\mathrm{V}_{\mathrm{CC}}\right)$ and timed from a voltage level of 1.4 V .

Table 2.

| Parameter ${ }^{1}$ | Limit at $\mathrm{T}_{\text {MIN, }}, \mathrm{T}_{\text {Max }}$ | Unit | Description |
| :---: | :---: | :---: | :---: |
| $\mathrm{f}_{\text {sclk }}$ | 5 | MHz max |  |
| $\mathrm{t}_{1}$ | 5 | ns min | $\overline{\mathrm{CS}}$ falling edge to first SCL falling edge |
| $\mathrm{t}_{2}$ | 20 | ns min | SCL high pulse width |
| $\mathrm{t}_{3}$ | 20 | ns min | SCL low pulse width |
| $\mathrm{t}_{4}$ | 15 | ns min | DIN setup time |
| $\mathrm{t}_{5}$ | 15 | ns min | DIN hold time |
| $\mathrm{t}_{6}$ | 20 | ns max | DOUT access time after SCL falling edge |
| $\mathrm{t}_{7}$ | 16 | ns max | $\overline{\mathrm{CS}}$ rising edge to DOUT high impedance |
| $\mathrm{t}_{8}$ | 15 | ns min | SCL rising edge to $\overline{C S}$ high |

[^1]

Figure 2. Detailed SPI Timing Diagram

## AD7879

## $I^{2} \mathrm{C}$ TIMING SPECIFICATIONS (AD7879-1)

$\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C} ; \mathrm{V}_{\mathrm{CC}}=1.6 \mathrm{~V}$ to 3.6 V , unless otherwise noted. Sample tested at $25^{\circ} \mathrm{C}$ to ensure compliance. All input signals are timed from a voltage level of 1.4 V .

Table 3.

| Parameter ${ }^{1}$ | Limit | Unit | Description |
| :---: | :---: | :---: | :---: |
| fscLk | 400 | kHz max |  |
| $\mathrm{t}_{1}$ | 0.6 | $\mu \mathrm{s}$ min | Start condition hold time, thd; sta |
| $\mathrm{t}_{2}$ | 1.3 | $\mu \mathrm{s}$ min | Clock low period, tıow |
| $\mathrm{t}_{3}$ | 0.6 | $\mu \mathrm{s}$ min | Clock high period, thigh |
| $\mathrm{t}_{4}$ | 100 | ns min | Data setup time, tsu; DAT |
| $\mathrm{t}_{5}$ | 300 | ns min | Data hold time, $\mathrm{t}_{\text {do; }}$ DAT |
| $\mathrm{t}_{6}$ | 0.6 | $\mu \mathrm{s}$ min | Stop condition setup time, $\mathrm{t}_{\text {su; }}$ sTo |
| $\mathrm{t}_{7}$ | 0.6 | $\mu \mathrm{s}$ min | Start condition setup time, $\mathrm{t}_{\text {Su; STA }}$ |
| $\mathrm{t}_{8}$ | 1.3 | $\mu \mathrm{s}$ min | Bus free time between stop and start conditions, tbuF |
| $\mathrm{t}_{\mathrm{R}}$ | 300 | ns max | Clock/data rise time |
| $\mathrm{t}_{\mathrm{F}}$ | 300 | ns max | Clock/data fall time |

[^2]

Figure 3. Detailed $I^{2} C$ Timing Diagram

## ABSOLUTE MAXIMUM RATINGS

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise specified.
Table 4.

| Parameter | Rating |
| :--- | :--- |
| V $_{\mathrm{cc}}$ to GND | -0.3 V to +3.6 V |
| Analog Input Voltage to GND | -0.3 V to $\mathrm{Vc}+0.3 \mathrm{~V}$ |
| AUX/VBAT to GND | -0.3 V to $\mathrm{V}_{\mathrm{cc}}+5 \mathrm{~V}$ |
| Digital Input Voltage to GND | -0.3 V to $\mathrm{Cc}+0.3 \mathrm{~V}$ |
| Digital Output Voltage to GND | -0.3 V to $\mathrm{V}_{\mathrm{cc}}+0.3 \mathrm{~V}$ |
| Input Current to Any Pin Except Supplies ${ }^{1}$ | 10 mA |
| ESD Rating (X+, Y+, X-, Y-) |  |
| $\quad$ Air Discharge Human Body Model | 15 kV |
| $\quad$ Contact Human Body Model | 10 kV |
| ESD Rating (All Other Pins) |  |
| $\quad$ Human Body Discharge | 4 kV |
| Field Induced Charge Device Model | 1 kV |
| $\quad$ Machine Model | 0.2 kV |
| Operating Temperature Range | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| Storage Temperature Range | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Junction Temperature | $150^{\circ} \mathrm{C}$ |
| WLCSP (4-Layer Board) |  |
| Power Dissipation | 866 mW |
| $\theta_{\mathrm{JA}}$ Thermal Impedance | $75^{\circ} \mathrm{C} / \mathrm{W}$ |
| LFCSP (4-Layer Board) |  |
| Power Dissipation | 2.138 W |
| $\theta_{\mathrm{JA}}$ Thermal Impedance | $30.4^{\circ} \mathrm{C} / \mathrm{W}$ |
| IR Reflow Peak Temperature | $260^{\circ} \mathrm{C}\left( \pm 0.5^{\circ} \mathrm{C}\right)$ |
| Lead Temperature (Soldering 10 sec$)$ | $300^{\circ} \mathrm{C}$ |

[^3]Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.


Figure 4. Circuit Used for Digital Timing

## ESD CAUTION

|  | ESD (electrostatic discharge) sensitive device. <br> Charged devices and circuit boards can discharge <br> without detection. Although this product features <br> patented or proprietary protection circuitry, damage <br> may occur on devices subjected to high energy ESD. <br> Therefore, proper ESD precautions should be taken to <br> avoid performance degradation or loss of functionality. |
| :--- | :--- |

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Figure 5. AD7879 WLCSP Pin Configuration


Figure 6. AD7879 LFCSP Pin Configuration


Figure 7. AD7879-1 WLCSP Pin Configuration


Figure 8. AD7879-1 LFCSP Pin Configuration

Table 5. Pin Function Descriptions

| Pin No. |  |  |  |
| :--- | :--- | :--- | :--- |
| WLCSP | LFCSP | Mnemonic | Description |

## AD7879

## TYPICAL PERFORMANCE CHARACTERISTICS

$\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=2.6 \mathrm{~V}, \mathrm{f}_{\text {SAMPLE }}=125 \mathrm{kHz}, \mathrm{f}_{\text {DCLK }}=16 \times \mathrm{f}_{\text {SAMPLE }}=2 \mathrm{MHz}$, unless otherwise noted.


Figure 9. Supply Current vs. Temperature


Figure 10. Supply Current vs. V Vcc


Figure 11. Full Power-Down IDD vs. Temperature


Figure 12. Change in ADC Gain vs. Temperature


Figure 13. Change in ADC Offset vs. Temperature


Figure 14. ADC INL Plot


Figure 15. ADC DNL Plot


Figure 16. Switch On Resistance vs. Vcc ( $X_{+}, Y_{+}$: $V_{\text {cc }}$ to Pin; $X_{-}, Y_{-}$: Pin to GND)


Figure 17 Switch On Resistance vs. Temperature ( $X+, Y+$ : $V_{c c}$ to Pin; $X-, Y-$ : Pin to GND)


Figure 18. ADC Code vs. Temperature (Fixed Analog Input)


Figure 19. Temperature Code vs. $V_{C C}$ for $25^{\circ} \mathrm{C}$


Figure 20. Typical FFT Plot for the Auxiliary Channels at 25 kHz Sampling Rate and 1 kHz Input Frequency


Figure 21. Typical Uncalibrated Accuracy for Battery Channel ( $25^{\circ} \mathrm{C}$ )

## TERMINOLOGY

## Integral Nonlinearity (INL)

INL is the maximum deviation from a straight line passing through the endpoints of the ADC transfer function. The endpoints of the transfer function are zero scale at 1 LSB below the first code transition and full scale at 1 LSB above the last code transition.

## Differential Nonlinearity (DNL)

DNL is the difference between the measured and the ideal 1 LSB change between any two adjacent codes in the ADC.

## Offset Error

Offset error is the deviation of the first code transition ( $00 \ldots 000$ ) to ( $00 \ldots 001$ ) from the ideal (AGND + 1 LSB).

## Gain Error

Gain error is the deviation of the last code transition ( $111 \ldots 110$ ) to ( $111 \ldots 111$ ) from the ideal ( $\mathrm{V}_{\text {REF }}-1 \mathrm{LSB}$ ) after the offset error has been adjusted out.

## On Resistance

On resistance is a measure of the ohmic resistance between the drain and the source of the switch drivers.

## AD7879

## THEORY OF OPERATION

The AD7879 is a complete, 12-bit data acquisition system for digitizing positional inputs from a 4 -wire resistive touch screen. To support this function, data acquisition on the AD7879 is highly programmable so as to ensure accurate and noise free results from the touch screen.
The core of the AD7879 is a high speed, low power, 12-bit analog-to-digital converter (ADC) with input multiplexer, on-chip track-and-hold, and on-chip clock. Conversion results are stored in on-chip results registers. The results from the auxiliary input or the battery input can be compared with high and low limits stored in limit registers to generate an out-of-limit $\overline{\mathrm{INT}}$.

The AD7879 also contains low resistance analog switches to switch the X and Y excitation voltages to the touch screen and the on-chip temperature sensor. The high speed SPI serial bus provides control of the devices, as well as communication with the device. The AD7879-1 is available with an $\mathrm{I}^{2} \mathrm{C}$ interface.
Operating from a single supply from 1.6 V to 3.6 V , the AD7879 offers a throughput rate of 105 kHz . The device is available in a $1.6 \mathrm{~mm} \times 2 \mathrm{~mm}$ 12-ball wafer level chip scale package (WLCSP) and in a $4 \mathrm{~mm} \times 4 \mathrm{~mm}$ 16-lead lead frame chip scale package.
The AD7879 has an on-chip sequencer that schedules a sequence of preprogrammed conversions. The conversion sequence starts automatically when the screen is touched, or at preset intervals, using the on-board timer.

To ensure that the AD7879 works well with different touch screens, the user can select the acquisition time. There is also a programmable delay to ensure that the voltage on the touch screen settles before a measurement is taken.
To help reduce noise in the system, the ADC takes up to 16 conversion results from each channel, and writes the average of the results to the register. To further improve the performance of the AD7879, the median filter can also be used if there is noise present in the system.

## TOUCH SCREEN PRINCIPLES

A 4-wire touch screen consists of two flexible, transparent, resistive-coated layers that are normally separated by a small air gap. The X layer has conductive electrodes running down the left and right edges, allowing the application of an excitation voltage across the X layer from left to right.

PLASTIC FILM WITH


Figure 22. Basic Construction of a Touch Screen
The Y layer has conductive electrodes running along the top and bottom edges, allowing the application of an excitation voltage down the Y layer from top to bottom.
Provided that the layers are of uniform resistivity, the voltage at any point between the two electrodes is proportional to the horizontal position for the X layer and the vertical position for the Y layer.
When the screen is touched, the two layers make contact. If only the X layer is excited, the voltage at the point of contact, and therefore the horizontal position, can be sensed at one of the Y layer electrodes. Similarly, if only the Y layer is excited, the voltage, and therefore the vertical position, can be sensed at one of the X layer electrodes. By switching alternately between $X$ and $Y$ excitation and measuring the voltages, the X and Y coordinates of the contact point can be found.

In addition to measuring the X and Y coordinates, it is also possible to estimate the touch pressure by measuring the contact resistance between the X and Y layers. The AD7879 is designed to facilitate this measurement.

Figure 23 shows an equivalent circuit of the analog input structure of the AD7879, showing the touch screen switches, the main analog multiplexer, the ADC, and the dual 3-to-1 multiplexer that selects the reference source for the ADC.


Figure 23. Analog Input Structure
The AD7879 can be set up to automatically convert either specific input channels or a sequence of channels. The results of the ADC conversions are stored in the results registers.

When measuring the ancillary analog inputs (AUX, TEMP, or VBAT), the ADC uses a $V_{C C}$ reference and the measurement is referred to GND.

## MEASURING TOUCH SCREEN INPUTS

When measuring the touch screen inputs, it is possible to measure using $\mathrm{V}_{\mathrm{CC}}$ as a reference, or to use the touch screen excitation voltage as the reference and to perform a ratiometric, differential measurement. The differential method is the default method and is selected by clearing the SER/DFR bit (Bit 9 in Control Register 2) to 0 . The single-ended method is selected by setting this bit to 1 .

## Single-Ended Method

Figure 24 illustrates the single-ended method for the Y position. For the X position, the excitation voltage is applied to $\mathrm{X}+$ and X - and the voltage is measured at $\mathrm{Y}+$.


Figure 24. Single-Ended Conversion of Touch Screen Inputs

The voltage seen at the input to the ADC in Figure 24 is

$$
\begin{equation*}
V_{I N}=V_{C C} \times \frac{R_{Y-}}{R_{Y T O T A L}} \tag{1}
\end{equation*}
$$

The advantage of the single-ended method is that the touch screen excitation voltage is switched off once the signal is acquired. Because a screen can draw over 1 mA , this is a significant consideration for a battery-powered system.

The disadvantage of the single-ended method is that voltage drops across the switches can introduce errors. Touch screens can have a total end-to-end resistance ranging from $200 \Omega$ to $900 \Omega$. By taking the lowest screen resistance of $200 \Omega$ and a typical switch resistance of $14 \Omega$, the user can reduce the apparent excitation voltage to $200 / 228 \times 100=87 \%$ of its actual value. In addition, the voltage drop across the low-side switch adds to the ADC input voltage. This introduces an offset into the input voltage; thus, it can never reach zero.

## Ratiometric Method

The ratiometric method illustrated in Figure 25 shows the negative input of the ADC reference tied to Y - and the positive input connected to $\mathrm{Y}+$. Thus, the screen excitation voltage provides the reference for the ADC. The input of the ADC is connected to $\mathrm{X}+$ to determine the Y position.


Figure 25. Ratiometric Conversion of Touch Screen Inputs
For greater accuracy, the ratiometric method has two significant advantages. One is that the reference to the ADC is provided from the actual voltage across the screen; therefore, any voltage dropped across the switches has no effect. The other advantage is that because the measurement is ratiometric, it does not matter if the voltage across the screen varies in the long term. However, it must not change after the signal has been acquired.

The disadvantage of the ratiometric method is that the screen must be powered up at all times because it provides the reference voltage for the ADC.

## TOUCH-PRESSURE MEASUREMENT

The pressure applied to the touch screen by a pen or finger can also be measured with the AD7879, using some simple calculations. The contact resistance between the X and Y plates is measured providing a good indication of the size of the depressed area and, therefore, the applied pressure. The area of the spot that is touched is proportional to the size of the object touching it. The size of this resistance ( $\mathrm{R}_{\text {TOUCH }}$ ) can be calculated using two different methods.

## First Method

The first method requires the user to know the total resistance of the X-plate tablet ( $\mathrm{R}_{\mathrm{X}}$ ). Three touch screen conversions are required: measurement of the X position, $\mathrm{X}_{\text {Position }}(\mathrm{Y}+$ input); measurement of the Y - input with the excitation voltage applied to $\mathrm{Y}+$ and $\mathrm{X}-(\mathrm{Z1}$ measurement); and measurement of the $\mathrm{X}+$ input with the excitation voltage applied to $\mathrm{Y}+$ and $\mathrm{X}-(\mathrm{Z} 2$ measurement).
These three measurements are illustrated in Figure 26.
The AD7879 has two special ADC channel settings that configure the X and Y switches for Z 1 and Z 2 measurement and store the results in the Z 1 and Z 2 results registers. The Z 1 measurement is ADC Channel 101b, and the result is stored in register with Read Address 0x0A. The Z 2 measurement is ADC Channel 100b, and the result is stored in register with Read Address 0x0B.
The touch resistance can then be calculated using the following equation:

$$
\begin{equation*}
R_{\text {TOUCH }}=\left(R_{\text {XPLATE }}\right) \times\left(X_{\text {POSITION }} / 4096\right) \times[(Z 2 / Z 1)-1] \tag{2}
\end{equation*}
$$



Figure 26. Three Measurements Required for Touch Pressure

## Second Method

The second method requires the user to know the resistance of the X-plate and Y-plate tablets. Three touch screen conversions are required: a measurement of the X position (Xposition), the Y position ( $\mathrm{Y}_{\text {posirtion }}$ ), and the Z 1 position.
The following equation also calculates the $\mathrm{R}_{\text {Touch: }}$

$$
\begin{align*}
& R_{\text {TOUCH }}=R_{\text {XPLATE }} \times\left(X_{\text {POSITIION }} / 4096\right) \times[(4096 / Z 1)-1]- \\
& R_{\text {YPLATE }} \times\left[1-\left(Y_{\text {POSITION }} / 4096\right)\right] \tag{3}
\end{align*}
$$

## TEMPERATURE MEASUREMENT

A temperature measurement option called the single conversion method is available on the AD7879. The conversion method requires only a single measurement on ADC Channel 001b. The results are stored in the results registers with Address 0x0D (TEMP). The AD7879 does not provide an explicit output of the temperature reading; the system must perform some external calculations. This method is based on an on-chip diode measurement.

The acquisition time is fixed at 16 ms for temperature measurement.

## Conversion Method

The conversion method makes use of the fact that the temperature coefficient of a silicon diode is approximately $-2.1 \mathrm{mV} /{ }^{\circ} \mathrm{C}$. However, this small change is superimposed on the diode forward voltage, which can have a wide tolerance. Therefore, it is necessary to calibrate by measuring the diode voltage at a known temperature to provide a baseline from which the change in forward voltage with temperature can be measured. This method provides a resolution of approximately $0.3^{\circ} \mathrm{C}$ and a predicted accuracy of $\pm 2^{\circ} \mathrm{C}$.
The temperature limit comparison is performed on the result in the TEMP results register, which is the measurement of the diode forward voltage. The values programmed into the high and low limits should be referenced to the calibrated diode forward voltage to make accurate limit comparisons.

## Temperature Calculations

If an explicit temperature reading in degrees Celsius is required, calculate for the single measurement method by

1. Calculate the scale factor of the ADC in degrees per LSB

Degrees per $L S B=$ ADC LSB size $/-2.1 \mathrm{mV}=$ ( $V_{C C} / 4096$ )/-2.1 mV
2. Save the ADC output $\left(\mathrm{D}_{\mathrm{CAL}}\right)$ at the calibration temperature, Tcal.
3. Take the ADC reading, $\mathrm{D}_{\mathrm{AMB}}$, at the temperature to be measured, $\mathrm{T}_{\text {AMB. }}$.
4. Calculate the difference in degrees between $\mathrm{T}_{\mathrm{CAL}}$ and $\mathrm{T}_{\mathrm{AMB}}$ by
$\Delta \mathrm{T}=\left(D_{A M B}-D_{C A L}\right) \times$ degrees per $L S B$
5. Add $\Delta \mathrm{T}$ to $\mathrm{T}_{\mathrm{CaL}}$.

## Example

Using $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V}$ as reference,
Degrees per LSB $=(2.5 / 4096) /-2.1 \times 10^{-3}=-0.291$
The ADC output is 983 decimal at $25^{\circ} \mathrm{C}$, equivalent to a diode forward voltage of 0.6 V .
The ADC output at $\mathrm{T}_{\text {AMB }}$ is 880 .

$$
\begin{aligned}
& \Delta T=(880-983) \times-0.291=30^{\circ} \mathrm{C} \\
& T_{A M B}=25+30=55^{\circ} \mathrm{C}
\end{aligned}
$$

## MEDIAN AND AVERAGING FILTERS

As explained in the Touch Screen Principles section, touch screens are composed of two resistive layers, normally placed over an LCD screen. Because these layers are in close proximity to the LCD screen, noise can be coupled from the screen onto these resistive layers, causing errors in the touch screen positional measurements.

The AD7879 contains a filtering block to process the data and discard the spurious noise before sending the information to the host. The goal of this block is not just the suppression of noise; the on-chip filtering also remarkably reduces the host processing loading.

The processing function consists of two filters that are applied to the converted results: the median filter and the averaging filter.

The median filter suppresses the isolated out-of-range noise and sets the number of measurements to be taken. These measurements are arranged in a temporary array, where the first value is the smallest measurement and the last value is the largest measurement. Bit 6 and Bit 5 in Control Register 2 (M1, M0) set the window of the median filter, and therefore, the number of measurements taken.

Table 6. Median Filter Size

| M1 | M0 | Function |
| :--- | :--- | :--- |
| 0 | 0 | Median filter does not operate |
| 0 | 1 | 4 measurements |
| 1 | 0 | 8 measurements |
| 1 | 1 | 16 measurements |

The averaging filter size determines the number of values to average. Bit 8 and Bit 7 in Control Register 2 (A1, A0) allow the average of $2,4,8$, or 16 samples. Only the final averaged result is written into the results register.

Table 7. Averaging filter Size

| A1 | A0 | Function |
| :--- | :--- | :--- |
| 0 | 0 | Average of 2 middle samples |
| 0 | 1 | Average of 4 middle samples |
| 1 | 0 | Average of 8 middle samples |
| 1 | 1 | Average of 16 samples |

When both filter values are 00 , only one measurement is transferred to the register map.

The number chosen with the M1 and M0 settings must be equal to or larger than the number chosen with the A1 and A0 settings. If both settings select the same number, the median filter is switched off.

Table 8. Median Averaging Filters (MAVF) Settings

|  | Function |
| :--- | :--- |
| $\mathrm{M}=\mathrm{A}$ | Median filter does not operate; output is the <br> average of $A$ converted results |
| $\mathrm{M}<\mathrm{A}$ | Not possible because the median filter size is <br> always bigger than the averaging window size |
| $\mathrm{M}>\mathrm{A}$ | Output is the average of the middle A values <br> from the array of $M$ measurements |

## Example

$\mathrm{M} 1, \mathrm{M} 0=11, \mathrm{~A} 1, \mathrm{~A} 0=10$; in this example the median filter has a window size of 16 . This means that 16 measurements are taken and arranged in descending order in a temporary array.

The averaging window size in this case is 8 . The output is an average of the middle 8 values of the 16 measurements taken with the median filter.


## AUXNBAT/GPIO PIN

Pin 1A (AUX/VBAT/GPIO) on the AD7879 can be programmed as either an auxiliary input to the ADC, as a battery monitoring input, or as a general-purpose digital input/output. To select the auxiliary measurement, set the ADC channel address to 011. To select a battery measurement, set the ADC channel address to 010. To select the GPIO, set Bit 13 in Control Register 2 (Address 0x02) to 1.

## AUXILIARY INPUT

The AD7879 has an auxiliary analog input, AUX. When selected, the signal on the AUX pin (AUX/VBAT/GPIO) is connected directly to the ADC input. This channel has a full-scale input range from 0 V to $\mathrm{V}_{\mathrm{cc}}$. The ADC channel addresses for AUX is 011, and the result is stored in Register 0x0C.

## BATTERY INPUT

The AD7879 can monitor battery voltages from 0.5 V to 5 V when the BAT measurement is selected. Figure 28 shows a block diagram of a battery voltage monitored through the VBAT pin. The voltage to the $\mathrm{V}_{\mathrm{cc}}$ pin ( $\mathrm{V}_{\mathrm{cc}} / \mathrm{REF}$ ) of the AD7879 is maintained at the desired supply voltage via the dc-to-dc regulator while the input to the regulator is monitored. This voltage on VBAT is divided down by 4 internally, so that a 5 V battery voltage is presented to the ADC as 1.25 V . To conserve power, the divider circuit is on only during the sampling of a voltage on VBAT. Note that the possible maximum input is 5 V .

The VBAT input is ADC Channel 010, and the result is stored in Register 0x0C.


Figure 28. Block Diagram of Battery Measurement Circuit
The maximum battery voltage that the AD7879 can measure changes when a different reference voltage is used. The maximum voltage that is measurable is $\mathrm{V}_{\mathrm{CC}} \times 4$ because this voltage gives a full-scale output from the ADC. The battery voltage can be calculated using the following formula:

$$
V_{B A T}(\mathrm{~V})=\left[(\text { Register Value }) \times V_{C C} \times 4\right] / 4095
$$

## LIMIT COMPARISON

The AUX measurement and the battery measurement can be compared with high and low limits stored on-chip. An out-of-limit result generates an alarm output at the INT pin $(\overline{\mathrm{PENIRQ}} / \overline{\mathrm{INT}} / \overline{\mathrm{DAV}})$ provided the $\overline{\mathrm{INT}}$ function is enabled. The high limit for both channels is stored in Register 0x04, while the low limit is stored in Register 0x05.
After a measurement from either AUX or VBAT is taken, it is compared with the high and low limits. The out-of-limit comparison sets a status bit in Control Register 3. There are separate status bits for both the high and low limits to indicate which limit was exceeded. The interrupt sources can be masked by clearing the corresponding enable bit in this register.

## GPIO

The AD7879 has one general-purpose logic input/output pin, GPIO (AUX/VBAT/GPIO). To enable the GPIO, set Bit 13 in Control Register 2 to 1 . If this bit it 0 , then the AUX/VBAT function is active on the pin. The other GPIO configuration bits have no effect, if the GPIO is not enabled.
The GPIO data bit is located in Bit 12 of the Control Register 2.

## Direction (Bit 11, Control Register2, Address 0x02)

Bit 11 sets the direction of the GPIO pin (AUX/VBAT/GPIO). When GPIO DIR $=0$, the pin is an output. Setting or clearing bits in the GPIO data bit (Register 0x02[12]) outputs a value on the GPIO pin.
When GPIO DIR $=1$, the pin is an input. An input value on the GPIO pin sets or clears the GPIO data bit (Register 0x02[12]). GPIO data register bits are read-only when GPIO DIR $=1$.

## Polarity (Bit 10, Control Register 2, Address 0x02)

When GPIO POL $=0$, the GPIO pin is active low. When GPIO $\mathrm{POL}=1$, the GPIO pin is active high. How this bit affects the GPIO operation also depends on the GPIO DIR bit.
If GPIO POL $=1$ and GPIO DIR $=1$, a 1 at the input pin sets the corresponding GPIO data register bit to 1 . A 0 at the input pin clears the corresponding GPIO data bit to 0 .
If GPIO POL $=1$ and GPIO DIR $=0$, a 1 in the GPIO data register bit puts a 1 on the corresponding GPIO output pin. A 0 in the GPIO data register bit puts a 0 on the GPIO output pin.
If GPIO POL $=0$ and GPIO DIR $=1$, a 1 at the input pin sets the corresponding GPIO data bit to 0 . A 0 at the input pin clears the corresponding GPIO data bit to 1 .

If GPIO POL $=0$ and GPIO DIR $=0$, a 1 in the GPIO data register bit puts a 0 on the corresponding GPIO output pin. A 0 in the GPIO data register bit puts a 1 on the GPIO output pin.

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## GPIO Interrupt Enable (Bit 12, Control Register 3, Address 0x03)

The GPIO pin can operate as an interrupt source to trigger the INT output. This is controlled by Bit 12 in Control Register 3. If the GPIO ALERT interrupt enable $=1$, the GPIO can trigger $\overline{\mathrm{INT}}$. If this bit $=0$, the GPIO cannot trigger INT.

INT is asserted if the GPIO data register bit is set when the GPIO is configured as an input, provided that $\overline{\mathrm{INT}}$ is enabled. $\overline{\mathrm{INT}}$ is triggered only when the GPIO is configured as an input, that is, when GPIO DIR $=1$.
$\overline{\text { INT }}$ is clear only when the GPIO signal or the GPIO enable changes.

## REGISTER MAP

Table 9. Register Table

| Address ${ }^{1}$ | Name | Description | Default Value | Type |
| :---: | :---: | :---: | :---: | :---: |
| 0x00 | Unused | Unused | 0x0000 | $\mathrm{R} / \overline{\mathrm{W}}$ |
| $0 \times 01$ | Control Register 1 | $\overline{\text { PENIRQ enable, channel selection for manual selection, } A D C \text { mode, }}$ acquisition time, and conversion timer | 0x0000 | $\mathrm{R} / \bar{W}$ |
| $0 \times 02$ | Control Register 2 | ADC power management, GPIO control, pen interrupt, averaging, median filter, software reset, and FCD | 0x4040 | $\mathrm{R} / \bar{W}$ |
| $0 \times 03$ | Control Register 3 | Status of high/low limit comparisons for TEMP, AUX/VBAT and enable bits to allow them to become interrupts; channel selection for slave/master mode | 0x0000 | R/W |
| 0x04 | AUX/VBAT high limit | AUX/VBAT high limit for comparison | 0x0000 | R/W |
| 0x05 | AUX/VBAT low limit | AUX/VBAT low limit for comparison | 0x0000 | R/W |
| $0 \times 06$ | TEMP high limit | TEMP high limit for comparison | 0x0000 | $\mathrm{R} / \overline{\mathrm{W}}$ |
| $0 \times 07$ | TEMP low limit | TEMP low limit for comparison | 0x0000 | $\mathrm{R} / \overline{\mathrm{W}}$ |
| $0 \times 08$ | X+ | $\mathrm{X}+$ measurement for Y position | 0x0000 | R |
| $0 \times 09$ | Y+ | $Y+$ measurement for $X$ position | 0x0000 | R |
| $0 \times 0 \mathrm{~A}$ | X + (Z1) | $\mathrm{X}+$ measurement for touch pressure calculation (Z1) | 0x0000 | R |
| $0 \times 0 \mathrm{~B}$ | $Y$ - (Z2) | Y- measurement for touch pressure calculation (Z2) | 0x0000 | R |
| $0 \times 0 \mathrm{C}$ | AUX/VBAT | AUX/VBAT measurement | 0x0000 | R |
| 0x0D | TEMP | Temperature conversion Measurement | 0x0000 | R |
| 0x0E | Revision and device ID | Revision and device ID | $\begin{aligned} & \text { 0x0379 (AD7879-1) } \\ & 0 \times 037 \mathrm{~A}(\text { AD7879) } \end{aligned}$ | R |

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## DETAILED REGISTER DESCRIPTIONS

All addresses and default values are expressed in hexadecimal.
Table 10. Control Register 1

| Address | Name | Data Bit | Description | Default Value |
| :---: | :---: | :---: | :---: | :---: |
| 0x01 | Disable $\overline{\text { PENIRQ }}$ | 15 | Pen interrupt enable. <br> $0=\overline{\text { PENIRQ }}$ pin is enabled. <br> $1=\overline{\text { PENIRQ }}$ is disabled and $\overline{\text { INT }}$ enabled. | 0x0000 |
|  | CHNL ADD[2:0] | 14:12 | $\begin{aligned} & \text { ADC Channel address for manual conversion (mode 01). } \\ & 111=\mathrm{X}+\text { input ( } \mathrm{Y} \text { position). } \\ & 110=Y+\text { input (X position). } \\ & 101=\mathrm{X}+(\mathrm{Z} 1) \text { input for touch-pressure calculation. } \\ & 100=Y-(Z 2) \text { input (used for touch-pressure measurement). } \\ & 011=\text { AUX input }{ }^{1} . \\ & 010=\text { VBAT input }{ }^{1} . \\ & 001=\text { temperature measurement. } \\ & 000=\text { not applicable. } \end{aligned}$ |  |
|  | ADC MODE[1:0] | 11:10 | ADC mode. <br> $00=$ no conversion. <br> $01=$ single conversion ${ }^{2}$. <br> $10=$ conversion sequence (slave mode) ${ }^{2}$. <br> 11 = conversion sequence (master mode). |  |
|  | ACQ[1:0] | 9:8 | ADC acquisition time. <br> $00=4$ clock periods $(2 \mu \mathrm{~s})$. <br> 01 = 8 clock periods ( $4 \mu \mathrm{~s}$ ). <br> $10=16$ clock periods ( $8 \mu \mathrm{~s}$ ). <br> 11 = 32 clock periods ( $16 \mu \mathrm{~s}$ ). <br> Note that the acquisition time does not apply to the temperature sensor channels; the temperature channel has a constant settling time of $16 \mu \mathrm{~s}$. |  |
|  | TMR[7:0] | 7:0 | Conversion interval timer. <br> Starts at $550 \mu \mathrm{~s}$ and continues to 9.440 ms in steps of $35 \mu \mathrm{~s}$. <br> Note that in slave mode, the conversion interval timer starts to count as soon as the conversion sequence is finished; in master mode, it starts to count again only if the screen remains touched. If the screen is released, the timer stops counting and, on the next screen touch, a conversion starts immediately. |  |

[^5]Table 11. Control Register 2

| Address | Name | Data Bit | Description | Default Value |
| :---: | :---: | :---: | :---: | :---: |
| 0x02 | PM[1:0] | 15:14 | ADC power management. <br> $00=$ full shutdown, the ADC, oscillator, BIAS, and temperature sensor are all powered down. <br> 01 = analog blocks to be powered down depend on the ADC mode. <br> If ADC mode is master mode; the ADC, oscillator, BIAS, and temperature sensor are powered down and must wake up when the user touches the screen. <br> If ADC mode is slave mode, the ADC and temperature sensor are powered down while not being used. They wake up automatically when required. The oscillator and BIAS are powered up because they are needed to measure time. This also applies to the single conversion mode. $10=$ ADC, BIAS, the oscillator is powered up continuously, irrespective of ADC mode. $11=\text { as } 01$ | 0x4040 |
|  | GPIO EN | 13 | $\begin{aligned} & \text { GPIO enable. } \\ & 0=\text { AUX/VBAT channel active. } \\ & 1=\text { GPIO enabled on AUX/VBAT/GPIO. } \end{aligned}$ |  |
|  | GPIO DAT | 12 | GPIO data bit. |  |
|  | GPIO DIR | 11 | $\begin{aligned} & \hline \text { GPIO direction. } \\ & 0=\text { output. } \\ & 1=\text { input. } \\ & \hline \end{aligned}$ |  |
|  | GPIO POL | 10 | GPIO polarity. <br> $0=$ the GPIO pin is active low. <br> $1=$ the GPIO pin is active high. |  |
|  | SER/ $\overline{\mathrm{DFR}}$ | 9 | SER/ $\overline{\mathrm{DFR}}$. <br> Selects normal (single-ended) or conversion. <br> $0=$ ratiometric (differential). <br> 1 = normal (single-ended). |  |
|  | A[1:0] | 8:7 | ADC averaging. <br> $00=2$ middle values averaged ( 1 measurement when median filter does not operate). <br> $01=4$ middle values averaged. <br> $10=8$ middle values averaged. <br> $11=16$ values averaged. |  |
|  | M [1:0] | 6:5 | Median filter size. <br> $00=$ median filter does not operate. <br> $01=4$ measurements. <br> $10=8$ measurements. <br> $11=16$ measurements. |  |
|  | SW/RST | 4 | Software reset; digital part is reset when this bit is set. |  |
|  | FCD[3:0] | 3:0 | ADC first conversion delay ${ }^{1}$. <br> Starts at $128 \mu \mathrm{~s}$ and goes all the way to 4.096 ms in steps of $128 \mu \mathrm{~s}$. |  |

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Table 12. Control Register 3

| Address | Name | Data <br> Bit | Description | Default Value |
| :---: | :---: | :---: | :---: | :---: |
| 0x03 | TEMP MASK | 15 | TEMP mask bit <br> $0=$ temperature measurement is allowed to cause interrupt <br> 1 = temperature measurement is not allowed to cause interrupt | 0x0000 |
|  | AUX/VBAT MASK | 14 | AUX/VBAT mask bit <br> $0=$ AUX/VBAT measurement is allowed to cause interrupt <br> 1 = AUX/VBAT measurement is not allowed to cause interrupt |  |
|  | INT MODE | 13 | $\overline{\overline{D A V} / \overline{I N T}}$ mode select $\begin{aligned} & 0=\text { enable } \overline{\mathrm{DAV}} \text { mode } \\ & 1=\text { enable } \overline{\mathrm{INT}} \text { mode } \end{aligned}$ <br> Note that this bit overrides any mask bits associated with individual channels |  |
|  | GPIO ALERT | 12 | GPIO interrupt enable <br> $0=$ GPIO can cause an alert on the $\overline{\text { INT }}$ output <br> 1 = mask GPIO from causing an alert on the $\overline{\mathrm{NT}}$ output |  |
|  | AUX/VBAT LOW | 11 | 1 = AUX/VBAT below low limit |  |
|  | AUX/VBAT HIGH | 10 | 1 = AUX/VBAT above high limit |  |
|  | TEMP LOW | 9 | 1 = TEMP below low limit |  |
|  | TEMP HIGH | 8 | 1 = TEMP above high limit |  |
|  | X+ | 7 | 1 = include measurement of Y position ( $\mathrm{X}+\mathrm{input}$ ) |  |
|  | Y+ | 6 | 1 = include measurement of $X$ position ( $Y+$ input) |  |
|  | Z1 | 5 | 1 = include Z 1 touch pressure measurement ( $\mathrm{X}+$ input) |  |
|  | Z2 | 4 | 1 = include measurement of Z 2 touch pressure measurement ( Y - input) |  |
|  | AUX | 3 | 1 = include measurement of AUX channel ${ }^{1}$ |  |
|  | VBAT | 2 | 1 = include measurement of battery monitor (VBAT) ${ }^{1}$ |  |
|  | TEMP | 1 | 1 = include temperature measurement |  |
|  | Not used | 0 | Unused |  |

${ }^{1}$ If GPIO is enabled, AUX and VBAT are both ignored. If AUX and VBAT are both selected, and GPIO is disabled, AUX is ignored, and VBAT is measured.

Table 13. Limit Registers

| Address | Data Bit | Description | Default Value |
| :--- | :--- | :--- | :--- |
| $0 \times 04$ | $15: 0$ | User-programmable AUX/VBAT high limit register | $0 \times 0000$ |
| $0 \times 05$ | $15: 0$ | User-programmable AUX/VBAT low limit register | $0 \times 0000$ |
| $0 \times 06$ | $15: 0$ | User-programmable TEMP high limit register | $0 \times 0000$ |
| $0 \times 07$ | $15: 0$ | User-programmable TEMP low limit register | $0 \times 0000$ |

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Table 14. Measurement Result Registers

| Address | Data Bit | Description | Default Value |
| :--- | :--- | :--- | :--- |
| $0 \times 08$ | $15: 0$ | Measured $X+$ input with Y excitation (Y position) | $0 \times 0000$ |
| $0 \times 09$ | $15: 0$ | Measured Y+input with $X$ excitation (X position) | $0 \times 0000$ |
| $0 \times 0 A$ | $15: 0$ | Measured $X+$ input with $X$ - and Y+ excitation (touch-pressure calculation Z1) | $0 \times 0000$ |
| $0 \times 0 B$ | $15: 0$ | Measured Y- input with $X$ - and Y+ excitation (touch-pressure calculation Z2) | $0 \times 0000$ |
| $0 \times 0 C$ | $15: 0$ | AUX/VBAT voltage measurement | $0 \times 0000$ |
| $0 \times 0 D$ | $15: 0$ | Temperature conversion measurement | $0 \times 0000$ |

Table 15. Revision/Device ID Register

| Address | Data Bit | Description | Default Value |
| :--- | :--- | :--- | :--- |
| $0 \times 0 \mathrm{E}$ | $15: 12$ | Unused | $0 \times 0379$ (AD7879-1) |
|  | $11: 8$ | Revision and device ID bits | $0 \times 037 \mathrm{~A}$ (AD7879) |
|  | $7: 0$ | Device ID |  |

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## CONTROL REGISTERS



Figure 29. Control Register 1

## CONTROL REGISTER 1

Control Register 1 (Address 0x01) contains the ADC channel address and the ADC mode bits. It sets the acquisition time and the timer. It also contains a bit to disable the pen interrupt. Control Register 1 should always be the last register programmed prior to starting conversions. Its power-on default value is 0x0000. To change any parameter after conversion has begun, the part should first be put into Mode 00. Make the changes; then reprogram Control Register 1, ensuring that it is always the last register programmed before conversions begin.

## Timer (Control Register 1, Bits[7:0])

The TMR bits in Control Register 1 enable the ADC to repeatedly perform a conversion or to perform a conversion sequence only once or at intervals of $35 \mu \mathrm{~s}$ from $550 \mu \mathrm{~s}$ up to 9.440 ms . In slave mode, the timer starts as soon as the conversion sequence is finished. In master mode, the timer starts at the end of a conversion sequence only if the screen remains touched. If the touch is released at any stage, then the timer stops. The next time the screen is touched, a conversion sequence immediately begins.

Table 16. Control Register 1 Timer Selection

| TMR | Function |
| :--- | :--- |
| 00000000 | Convert one time only (default) |
| 00000001 | Every $550 \mu \mathrm{~s}$ |
| 00000010 | Every $585 \mu \mathrm{~s}$ |
| 00000011 | Every $620 \mu \mathrm{~s}$ |
| $\ldots$ | $\ldots$ |
| 11111101 | Every 9.370 ms |
| 11111110 | Every 9.405 ms |
| 1111111 | Every 9.440 ms |

## Acquisition Time (Control Register 1, Bits[9:8])

The ACQ bits in Control Register 1 allow the selection of acquisition times for the ADC of $2 \mu \mathrm{~s}$ (default), $4 \mu \mathrm{~s}, 8 \mu \mathrm{~s}$, or $16 \mu \mathrm{~s}$. The user can program the ADC with an acquisition time suitable for the type of signal being sampled. For example, signals with large RC time constants can require longer acquisition times.

Table 17. Acquisition Time Selection

| ACQ1 | ACQ0 | Function |
| :--- | :--- | :--- |
| 0 | 0 | 4 clock periods $(2 \mu \mathrm{~s})$ |
| 0 | 1 | 8 clock periods $(4 \mu \mathrm{~s})$ |
| 1 | 0 | 16 clock periods $(8 \mu \mathrm{~s})$ |
| 1 | 1 | 32 clock periods $(16 \mu \mathrm{~s})$ |

## ADC Mode (Control Register 1, Bits[1 1:10])

The mode bits select the operating mode of the ADC. The AD7879 has three operating modes. These are selected by writing to the mode bits in Control Register 1. If the mode bits are 00 , no conversion is performed.

Table 18. Control Register 1 Mode Selection

| ADC <br> MODE1 | ADC <br> MODEO | Function |
| :--- | :--- | :--- |
| 0 | 0 | Do not convert (default) <br> Single-channel conversion; the AD7879 is <br> in slave mode |
| 1 | 1 | 0 | | Sequence 0 ; the AD7879 is in slave mode |
| :--- |
| 1 |

If the mode bits are 01 , a single conversion is performed on the channel selected by writing to the channel bits of Control Register 1 (Bit 12 to Bit 14). At the end of the conversion, if the TMR bits in Control Register 1 are set to 00000000 , the mode bits revert to 00 and the ADC returns to no convert mode until a new conversion is initiated by the host. Setting the TMR bits to a value other than 00000000 causes the conversion to be repeated.
The AD7879 can also be programmed to automatically convert a sequence of selected channels. The two modes for this type of conversion are slave mode and master mode.

For slave mode operation, the channels to be digitized are selected by setting the corresponding bits in Control Register 3. Conversion is initiated by writing 10 b to the mode bits of Control Register 1. The ADC then digitizes the selected channels and stores the results in the corresponding results registers. At the end of the conversion, if the TMR bits in Control Register 1 are set to 00000000 , the mode bits revert to 00 and the ADC returns to no convert mode until a new conversion is initiated by the host. Setting the TMR bits to a code other than 00000000 causes the conversion sequence to be repeated.

For master mode operation, the channels to be digitized are written to the Control Register 3. Master mode is then selected by writing 11 to the mode bits in Control Register 1. In this mode, the wake-up on touch feature is active; therefore, conversion does not immediately begin. The AD7879 waits until the screen is touched before beginning the sequence of conversions. The ADC then digitizes the selected channels; and the results are written to the result registers. The AD7879 waits for the screen to be touched again, or for a timer event if the screen remains touched, before beginning another sequence of conversions.

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## ADC Channel (Control Register 1 Bits[14:12])

The ADC channel is selected by Bits[14:12] of Control Register 1 (CHNL ADD2 to CHNL ADD0). A complete list of channel addresses is given in Table 19.

For Mode 0 (single-channel) conversion, the channel is selected by writing the appropriate CHNL ADD2 to CHNL ADD0 code to Control Register 1.
For sequential channel conversion, channels to be converted are selected by setting bits corresponding to the channel number in the Control Register 3 for slave and master mode sequencing.

For both single-channel and sequential conversion, a normal conversion (single-ended) is selected by clearing the SER/ $\overline{\mathrm{DFR}}$ bit in Control Register 2 (Bit 9). Ratiometric (differential) conversion is selected by setting the SER/DFR bit.

## $\overline{\text { PENIRQ Enable (Control Register 1, Bit 15) }}$

The AD7879 has a dual function output that performs as $\overline{\text { PENIRQ }}$ or $\overline{\text { INT }}$ depending on the pen interrupt enable bit (Bit 15 of Control Register 1). When this bit is set to 0 , the pin is working as a pen interrupt and it goes low whenever the screen is touched. When the pen interrupt enable bit is set to 1 , the pin interrupt request is disabled and the pin functions as $\overline{\mathrm{INT}}$.

Table 19. Codes for Selecting Input Channel and Normal or Ratiometric Conversion

| Channel | SER/DFR | CHNL ADD[2:0] | Analog Input | X Switches | Y Switches | +REF | -REF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 111 | $\mathrm{X}+$ (Y position) | Off | On | Y+ | Y- |
| 1 | 0 | 110 | $\mathrm{Y}+$ (X position) | On | Off | X+ | X- |
| 2 | 0 | 101 | $\mathrm{X}+$ (Z1 touch pressure) | X+ off, X - on | Y+ on, $Y$ - off | Y+ | X- |
| 3 | 0 | 100 | Y- (Z2 touch pressure) | X+ off, X - on | Y+on, Y - off | Y+ | X- |
| 4 | 0 | 011 | AUX | Off | Off | $V_{\text {cc }}$ | GND |
| 5 | 0 | 010 | VBAT | Off | Off | $V_{\text {cc }}$ | GND |
| 6 | 0 | 001 | TEMP | Off | Off | V cc | GND |
|  | 0 | 000 | Invalid address |  |  |  |  |
| 7 | 1 | 111 | $\mathrm{X}+\mathrm{Y}$ position) | Off | On | $\mathrm{V}_{\text {cc }}$ | GND |
| 8 | 1 | 110 | Y+(X position) | On | Off | $V_{\text {cc }}$ | GND |
| 9 | 1 | 101 | $\mathrm{X}+$ (Z1 touch pressure) | Off | Off | $V_{\text {cc }}$ | GND |
| 12 | 1 | 100 | Y- (Z2 touch pressure) | Off | Off | V cc | GND |
| 13 | 1 | 011 | AUX | Off | Off | $V_{\text {cc }}$ | GND |
| 14 | 1 | 010 | VBAT | Off | Off | $V_{\text {cc }}$ | GND |
| 15 | 1 | 001 | TEMP | Off | Off | Vcc | GND |
|  | 1 | 000 |  | Inva | ess |  |  |

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Figure 30. Control Register 2

## CONTROL REGISTER 2

Control Register 2 (Address 0x02) contains the power management bits, the GPIO settings, the SER/ $\overline{\mathrm{DFR}}$ bit (to choose single or differential methods of touch screen measurement), the averaging and median filter settings, a bit that allows resetting the part, and the first conversion delay bits. Its power-on default value is $0 \times 4040$. See the Detailed Register Descriptions section for more information on the control registers.

## First Conversion Delay (Control Register 2, Bits[3:0])

The first conversion delay (FCD) bits in Control Register 2 program a delay from $128 \mu \mathrm{~s}$ (default) up to 4.096 ms before the first conversion to allow the ADC time to power up. This delay also occurs before conversion of the X and Y coordinate channels to allow extra time for screen settling, and after the last conversion in a sequence to precharge $\overline{\text { PENIRQ }}$.

Table 20. First Conversion Delay Selection

| FCD | Function |
| :--- | :--- |
| 0000 | $128 \mu \mathrm{~s}$ |
| 0001 | $256 \mu \mathrm{~s}$ |
| 0010 | $384 \mu \mathrm{~s}$ |
| 0011 | $512 \mu \mathrm{~s}$ |
| 0100 | $640 \mu \mathrm{~s}$ |
| 0101 | $768 \mu \mathrm{~s}$ |
| 0110 | $896 \mu \mathrm{~s}$ |
| 0111 | 1.024 ms |
| 1000 | 1.152 ms |
| 1001 | 1.280 ms |
| 1010 | 1.536 ms |
| 1011 | 1.792 ms |
| 1100 | 2.048 ms |
| 1101 | 2.560 ms |
| 1110 | 3.584 ms |
| 1111 | 4.096 ms |

## Power Management (Control Register 2, Bits[15:14])

The power management (PM) bits in Control Register 2 allow the power management features of the ADC to be programmed. If the PM bits are 00 , the ADC is permanently powered down. This overrides any setting of the mode bits in Control Register 1. If the PM bits are 01 , both the ADC and the reference power down when the ADC is not converting. If the PM bits are 10 or 11, the analog blocks to be powered down depend on the ADC mode settings. Power management overrides the ADC modes.

Table 21. Power Management Selection

| PM1 | PM0 | Function |
| :--- | :--- | :--- |
| 0 | 0 | Full shutdown; ADC, oscillator, BIAS, and <br> temperature sensor are all turned off. The only <br> way of coming out of this mode is to write to the <br> part over the serial interface and change the PM <br> bits. This setting overrides any other setting on <br> the part, including the ADC mode bits. <br> The analog blocks to be powered down depend <br> on the ADC mode settings. If the ADC mode is set <br> to master mode, the ADC, BIAS, temperature <br> sensor, and oscillator are powered down and <br> must wake up when the user touches the screen. <br> If the ADC mode is set to slave mode, the ADC <br> and the TEMP sensor are powered down while <br> not being used. They wake up automatically <br> when required. The oscillator and BIAS are <br> powered up because they are needed to measure <br> time. This also applies to the single-conversion <br> mode. <br> ADC, BIAS, and the oscillator are powered up <br> continuously irrespective of ADC mode. |
| 1 | 0 | As 01. |
| 1 |  |  |



Figure 31. Control Register 3

## CONTROL REGISTER 3

Control Register 3 (Address 0x03) includes the interrupt register (Bits[15:8]) and Control Register 3 (Bits[7:0]).

## Sequencer

The sequencer bits control which channels are converted during a conversion sequence in both slave and master mode.

To include a measurement in a sequence, the relevant bit must be set in the sequence. Setting Bit 7 includes a measurement on the $\mathrm{X}+$ channel (Y position). Setting Bit 6 includes a measurement on the $\mathrm{Y}+$ channel ( X position), and so on.
Figure 32 illustrates the correspondence between the bits in Control Register 3 and the various measurements. Bit 0 is not used.


Figure 32. Conversion Modes

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Figure 33. Conversion Sequence

## INTERRUPTS

The AD7879 has a dual function interrupt output, $\overline{\text { INT, }}$, as well as a pen down interrupt, $\overline{\text { PENIRQ. The } \overline{\text { INT }} \text { output can be con- }}$ figured as a data available interrupt, as an out of limit interrupt, or as a GPIO interrupt.

## INT—Data Available

The behavior of the interrupt output is controlled by Bit 13 in Control Register 3. In default mode, $\overline{\mathrm{INT}}$ operates as a data available interrupt (Bit $13=0$ ). When the AD7879 has finished a conversion or a conversion sequence, the interrupt asserts to let the host know that new ADC data is available in the result registers.
While the ADC is idle or is converting, $\overline{\mathrm{INT}}$ is high. When the ADC has finished converting and new data has been written to the results registers, $\overline{\mathrm{INT}}$ goes low. Reading the result registers
resets INT to a high condition. INT is also reset if a new conversion is started by the AD7879 because the timer expired. The host should read the results registers only when INT is low. To ensure correct operation of the $\overline{\mathrm{DAV}}$ mode when using the SPI interface it is necessary to write $0 \times 0000$ to Register $0 \times 81$ after a set of register reads. This clears the internal data read signal.


Figure 34. Operation of $\overline{I N T}$ Output
When the on-board timer is programmed to perform automatic conversions, limited time is available to the host to read the results registers before another sequence of conversions begins. The $\overline{\mathrm{INT}}$ signal is reset high when the timer expires, and the host should not access the results registers while $\overline{\mathrm{INT}}$ is high.

## $\overline{\text { INT }}$ —Out of Limits

The $\overline{\mathrm{INT}}$ pin operates as an alarm or interrupt output when Bit 13 in Register 0x03 is set to 1 . The output goes low if any one of the interrupt sources is asserted. The results of high and low limit comparisons on the AUX, VBAT, and TEMP channels are interrupt sources. An out-of-limit comparison sets a status bit in the interrupt register. There are separate status bits for both the high and low limits on each channel to indicate which limit was exceeded. The interrupt sources can be masked by clearing the corresponding enable bit in this register. There is one enable bit per channel.

## PENIRQ—Pen Interrupt

The pen interrupt request output ( $\overline{\text { PENIRQ }}$ ) goes low whenever the screen is touched and the $\overline{\text { PENIRQ }}$ enable bit is set to 0 (Control Register 1, Bit 15). When $\overline{\text { PENIRQ }}$ enable is set to 1 , the pen interrupt request output is disabled.

The pen interrupt equivalent output circuitry is outlined in Figure 35. This is a digital logic output with an internal $50 \mathrm{k} \Omega$ pull-up resistor, which means it does not need an external pullup. The $\overline{\text { PENIRQ }}$ output idles high, and the $\overline{\text { PENIRQ }}$ circuitry is always enabled in master mode ( ADC mode $=11$ ), except during conversions.


Figure 35. $\overline{\overline{P E N I R Q}}$ Output Equivalent Circuit

When the screen is touched, $\overline{\text { PENIRQ }}$ goes low. This generates an interrupt request to the host. When the screen touch ends, and if the ADC is idle, $\overline{\text { PENIRQ }}$ immediately goes high. If the ADC is converting, $\overline{\text { PENIRQ goes high when the ADC becomes }}$ idle. The $\overline{\text { PENIRQ }}$ operation for these two conditions is shown in Figure 36.


Figure 36. $\overline{\text { PENIRQ Operation for ADC Idle and ADC Converting }}$

## SYNCHRONIZING THE AD7879 TO THE HOST CPU

The two recommended methods for synchronizing the AD7879 to its host CPU are slave mode (in which the mode bits can be either 01 b or 10 b ) and master mode (in which the mode bits are 11b).
In master mode (ADC mode bits $=11 \mathrm{~b}), \overline{\text { PENIRQ }}$ mode can be used as an interrupt to the host. When PENIRQ goes low to indicate that the screen has been touched, the host is awakened. The host can then program the AD7879 to convert in any mode and read the results after the conversions are completed.
In master mode, $\overline{\mathrm{INT}}$ or $\overline{\mathrm{DAV}}$ can also be used as an interrupt to the host. The host should first define a conversion sequence in Control Register 3, initialize the AD7879 in Mode 11b and enable $\overline{\mathrm{INT}}$ or DAV using Bit 15 in Control Register 1 and Bit 13 in Control Register 3. The host can then enter sleep mode to conserve power. The wake-up on-touch feature of the AD7879 is active in this mode; therefore, when the screen is touched, the programmed sequence of conversions automatically begins. When the $\overline{\mathrm{INT}}$ or $\overline{\mathrm{DAV}}$ signal asserts, the host reads the new data available in the AD7879 results registers and returns to sleep mode. This method can significantly reduce the load on the host.
Figure 37 shows how the $\overline{\text { PENIRQ }}$ circuit is enabled. The wakeup on-touch circuit and the $\overline{\text { PENIRQ }}$ circuit are enabled only in master mode (ADC mode $=11$ ). In slave mode, the $\overline{\text { PENIRQ } / ~}$ $\overline{\mathrm{DAV}} / \overline{\mathrm{INT}}$ pin can output only $\overline{\mathrm{DAV}}$ or $\overline{\mathrm{INT}}$ signals.


## SERIAL INTERFACE

The AD7879 is available with an serial peripheral interface (SPI). The AD7879-1 is available with an $\mathrm{I}^{2} \mathrm{C}^{\ominus}$-compatible interface. Both parts are the same, with the exception of the serial interface. It is recommended not to write to addresses outside the register map.

## SPI INTERFACE

The AD7879 has a 4 -wire SPI. The SPI has a data input pin (DIN) for inputting data to the device, a data output pin (DOUT) for reading data back from the device, and a data clock pin (SCL) for clocking data into and out of the device. A chip select pin ( $\overline{\mathrm{CS}}$ ) enables or disables the serial interface. $\overline{\mathrm{CS}}$ is required for correct operation of the SPI interface. Data is clocked out of the AD7879 on the negative edge of SCL and data is clocked into the device on the positive edge of SCL.

## SPI Command Word

All data transactions on the SPI bus begin with the master taking $\overline{\mathrm{CS}}$ from high to low and sending out the command word. This indicates to the AD7879 whether the transaction is a read or a write, and gives the address of the register from which to begin the data transfer. The bit map in Table 22 shows the SPI command word.

Table 22.
MSB

| $\mathbf{1 5}$ | $\mathbf{1 4}$ | $\mathbf{1 3}$ | $\mathbf{1 2}$ | $\mathbf{1 1}$ | $\mathbf{1 0}$ | $\mathbf{9 : 0}$ |
| :--- | :---: | :---: | :---: | :---: | :---: | :--- |
| 1 | 1 | 1 | 0 | 0 | $\mathrm{R} / \overline{\mathrm{W}}$ | RSB |

Bits[15:11] of the command word must be set to 11100 to successfully begin a bus transaction.
Bit 10 is the read/write bit; 1 indicates a read, and 0 indicates a write.

Bits[9:0] contain the target register address. When reading or writing to more than one register, this address indicates the address of the first register to be written to or read from.

## Writing Data

Data is written to the AD7879 in 16-bit words. The first word written to the device is the command word, with the read/write bit set to 0 . The master then supplies the 16 -bit input data-word on the DIN line. The AD7879 clocks the data into the register addressed in the command word. If there is more than one word of data to be clocked in, the AD7879 automatically increments the address pointer and clocks the next data-word into the following register.
The AD7879 continues to clock in data on the SDA line until either the master finishes the write transition by pulling $\overline{\mathrm{CS}}$ high, or until the address pointer reaches its maximum value. The AD7879 address pointer does not wrap around. When it reaches its maximum value, any data provided by the master on the DIN line is ignored by the AD7879.


Figure 38. Single Register Write, SPI Timing


Figure 39. Sequential Register Write SPI Timing


## NOTES

1. DATA BITS ARE LATCHED ON SCL RISING EDGES. SCL CAN IDLE HIGH OR LOW BETWEEN WRITE OPERATIONS.
2. THE 16-BIT CONTROL WORD MUST BE WRITTEN ON SDI: 5 BITS FOR ENABLE WORD, 1 BIT FOR R $\bar{W}$, AND 10 BITS FOR REGISTER ADDRESS.
3. THE REGISTER DATA IS READ BACK ON THE DOUT PIN.
4. X DENOTES DON'T CARE.
5. XXX DENOTES HIGH IMPEDANCE THREE-STATE OUTPUT.
6. $\overline{C S}$ IS HELD LOW UNTIL ALL REGISTER BITS HAVE BEEN READ BACK.
7. 16-BIT COMMAND WORD SETTINGS FOR SINGLE READBACK OPERATION:

CW[15:11] = 11100 (ENABLE WORD)
$\mathrm{CW}[10]=1(\mathrm{R} / \overline{\mathrm{W}})$
CW[9:0] = [AD9, AD8, AD7, AD6, AD5, AD4, AD3, AD2, AD1, AD0] (10-BIT MSB JUSTIFIED REGISTER ADDRESS)
Figure 40. Single Register Read Back SPI Timing

## Reading Data

A read transaction begins when the master writes the command word to the AD7879 with the read/write bit set to 1 . The master then supplies 16 clock pulses per data-word to be read, and the AD7879 clocks out data from the addressed register on the SDA line. The first data-word is clocked out on the first falling edge of SCL following the command word, as shown in Figure 40.

The AD7879 continues to clock out data on the DOUT line provided the master continues to supply the clock signal on SCL. The read transaction finishes when the master takes $\overline{\mathrm{CS}}$ high. If the AD7879 address pointer reaches its maximum value, the AD7879 repeatedly clocks out data from the addressed register. The address pointer does not wrap around.

## AD7879



## notes

1. MULTIPLE REGISTERS CAN BE READ BACK CONTINUOUSLY.
2. THE 16-BIT CONTROL WORD MUST BE WRITTEN ON SDA: 5 BITS FOR ENABLE WORD, 1 BIT FOR R/W, AND 10 BITS FOR REGISTER ADDRESS
3. THE ADDRESS AUTOMATICALLY INCREMENTS WITH EACH 16-BIT DATA-WORD BEING READ BACK ON THE SDA PIN.
4. CS IS HELD LOW UNTIL ALL REGISTER BITS HAVE BEEN READ BACK.
5. X DENOTES DON'T CARE.
6. XXX DENOTES HIGH IMPEDANCE THREE-STATE OUTPUT.
7. 16-BIT COMMAND WORD SETTINGS FOR SEQUENTIAL READBACK OPERATION:
$\mathrm{CW}[15: 11]=11100$ (ENABLE WORD)
$\mathrm{CW}[10]=1(\mathrm{R} / \overline{\mathrm{W}})$
CW[9:0] = [AD9, AD8, AD7, AD6, AD5, AD4, AD3, AD2, AD1, AD0] (STARTING MSB JUSTIFIED REGISTER ADDRESS)
Figure 41. Sequential Register Read Back SPI Timing

## $\mathbf{I}^{2}$ C-COMPATIBLE INTERFACE

The AD7879-1 supports the industry standard 2-wire $\mathrm{I}^{2} \mathrm{C}$ serial interface protocol. The two wires associated with the $\mathrm{I}^{2} \mathrm{C}$ timing are the SCL and SDA inputs. The SDA is an I/O pin that allows both register write and register read back operations. The AD7879-1 is always a slave device on the $\mathrm{I}^{2} \mathrm{C}$ serial interface bus.
It has a 7-bit device address, Address 0101 1XX. The lower two bits are set by tying the ADD0 and ADD1 pins high or low. The AD7879-1 responds when the master device sends its device address over the bus. The AD7879-1 cannot initiate data transfers on the bus.

Table 23. AD7879-1 I ${ }^{2} \mathrm{C}$ Device Address

| ADD1 | ADD0 | $I^{2}$ C Address |
| :--- | :--- | :--- |
| 0 | 0 | 0101100 |
| 0 | 1 | 0101101 |
| 1 | 0 | 0101110 |
| 1 | 1 | 0101111 |

## Data Transfer

Data is transferred over the $\mathrm{I}^{2} \mathrm{C}$ serial interface in 8 -bit bytes. The master initiates a data transfer by establishing a start condition, defined as a high-to-low transition on the serial data line, SDA, while the serial clock line, SCL, remains high. This indicates that an address/data stream follows.

All slave peripherals connected to the serial bus respond to the start condition and shift in the next eight bits, consisting of a 7-bit address (MSB first) plus an R/W bit that determines the direction of the data transfer. The peripheral whose address corresponds to the transmitted address responds by pulling the data line low during the ninth clock pulse. This is known as the acknowledge bit. All other devices on the bus then remain idle while the selected device waits for data to be read from, or written to it. If the $R / \bar{W}$ bit is a 0 , the master writes to the slave device. If the $R / \bar{W}$ bit is a 1 , the master reads from the slave device.
Data is sent over the serial bus in a sequence of nine clock pulses (eight bits of data followed by an acknowledge bit from the slave device). Transitions on the data line must occur during the low period of the clock signal and remain stable during the high period, because a low-to-high transition when the clock is high can be interpreted as a stop signal. The number of data bytes transmitted over the serial bus in a single read or write operation is limited only by what the master and slave devices can handle.
When all data bytes are read or written, a stop condition is established. A stop condition is defined by a low-to-high transition on SDA while SCL remains high. If the AD7879 encounters a stop condition, it returns to its idle condition.


NOTES

1. A START CONDITION AT THE BEGINNING IS DEFINED AS A HIGH-TO-LOW TRANSITION ON SDA WHILE SCL REMAINS HIGH.
2. A STOP CONDITION AT THE END IS DEFINED AS A LOW-TO-HIGH TRANSITION ON SDA WHILE SCL REMAINS HIGH.
3. 7-BIT DEVICE ADDRESS [DEV A6:DEV A0] = [ 0101011 XX ], WHERE THE Xs ARE DON'T CARE BITS.
4. REGISTER DATA [D15:D8] AND REGISTER DATA [D7:D0] ARE ALWAYS SEPARATED BY A LOW ACK BIT.

Figure 42. Example of $1^{2} C$ Timing for Single Register Write Operation

## Writing Data over the $I^{2} C$ Bus

The process of writing to the AD7879-1 over the $\mathrm{I}^{2} \mathrm{C}$ bus is shown in Figure 42 and Figure 44. The device address is sent over the bus followed by the R/W bit set to 0 . This is followed by two bytes of data that contain the 10 -bit address of the internal data register to be written. The address is contained in the 8 LSBs of the register address byte. The bit map in Table 24 shows the register address byte.

Table 24.
MSB
LSB

| $\mathbf{7}$ | $\mathbf{6}$ | $\mathbf{5}$ | $\mathbf{4}$ | $\mathbf{3}$ | $\mathbf{2}$ | $\mathbf{1}$ | $\mathbf{0}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Register Address |  |  |  |  |  |  |  |
| Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |

The third data byte contains the 8 MSBs of the data to be written to the internal register. The fourth data byte contains the 8 LSBs of data to be written to the internal register.
The AD7879-1 address pointer register automatically increments after each write. This allows the master to sequentially write to all registers on the AD7879-1 in the same write transaction. However, the address pointer register does not wrap around after the last address.

Any data written to the AD7879-1 after the address pointer has reached its maximum value is discarded.

All registers on the AD7879-1 have 16 bits. Two consecutive 8 -bit data bytes are combined and written to the 16 -bit registers. To avoid errors, all writes to the device must contain an even number of data bytes.
To finish the transaction, the master generates a stop condition on SDA, or generates a repeat start condition if the master is to maintain control of the bus.

## Reading Data Over the I ${ }^{2} \mathrm{C}$ Bus

To read from the AD7879-1, the address pointer register must first be set to the address of the required internal register. The master performs a write transaction and writes to the AD7879-1 to set the address pointer. The master then outputs a repeat start condition to keep control of the bus, or if this is not possible, the master ends the write transaction with a stop condition. A read transaction is initiated, with the $\mathrm{R} / \overline{\mathrm{W}}$ bit set to 1 .

The AD7879-1 supplies the upper eight bits of data from the addressed register in the first read back byte, followed by the lower eight bits in the next byte. This is shown in Figure 43 and Figure 44.

Because the address pointer automatically increases after each read, the AD7879-1 continues to output readback data until the master puts a no acknowledge and a stop condition on the bus. If the address pointer reaches its maximum value, and the master continues to read from the part, the AD7879-1 repeatedly sends data from the last register addressed.

## AD7879



## NOTES

1. A START CONDITION AT THE BEGINNING IS DEFINED AS A HIGH-TO-LOW TRANSITION ON SDA WHILE SCL REMAINS HIGH.
2. A STOP CONDITION AT THE END IS DEFINED AS A LOW-TO-HIGH TRANSITION ON SDA WHILE SCL REMAINS HIGH.
3. THE MASTER GENERATES THE ACK AT THE END OF THE READBACK TO SIGNAL THAT IT DOES NOT WANT ADDITIONAL DATA.
4. 7-BIT DEVICE ADDRESS [DEV A6:DEV A0] = $\begin{array}{llll}0 & 1 & 0 & 1\end{array} 1 \mathrm{XX}$ ], WHERE THE TWO LSB Xs ARE DON'T CARE BITS.
5. REGISTER DATA [D15:D8] AND REGISTER DATA [D7:D0] ARE ALWAYS SEPARATED BY A LOW ACK BIT.
6. THE R/W BIT IS SET TO A1 TO INDICATE A READBACK OPERATION.

Figure 43. Example of $I^{2} C$ Timing for Single Register Read Back Operation

WRITE


## AD7879

## GROUNDING AND LAYOUT

For detailed information on grounding and layout considerations for the AD7879, refer to the AN-577 Application Note, Layout and Grounding Recommendations for Touch Screen Digitizers.

## CHIP SCALE PACKAGES

The lands on the chip scale package (CP-16-10) are rectangular. The printed circuit board (PCB) pad for these should be 0.1 mm longer than the package land length, and 0.05 mm wider than the package land width. Center the land on the pad to maximize the solder joint size.
The bottom of the chip scale package has a central thermal pad. The thermal pad on the printed circuit board should be at least
ance of at least 0.25 mm between the thermal pad and the inner edges of the land pattern on the PCB. Thermal vias can be used on the printed circuit board thermal pad to improve thermal performance of the package. If vias are used, they should be incorporated in the thermal pad at a 1.2 mm pitch grid. The via diameter should be between 0.3 mm and 0.33 mm , and the via barrel should be plated with 1 oz . of copper to plug the via.
Connect the PCB thermal pad to GND.

## WLCSP ASSEMBLY CONSIDERATIONS

For detailed information on the WLCSP PCB assembly and reliability, see the AN-617 Application Note, MicroCSP ${ }^{m w}$ Wafer Level Chip Scale Package. as large as this exposed pad. To avoid shorting, provide a clear-


## OUTLINE DIMENSIONS



Figure 46. 12-Ball Wafer Level Chip Scale Package [WLCSP] (CB-12-1)
Dimensions shown in millimeters


COMPLIANT TO JEDEC STANDARDS MO-220-VGGC
Figure 47. 16-Lead Lead Frame Chip Scale Package [LFCSP_VQ]
4 mm x 4mm Very Thin Quad
(CP-16-10)
Dimensions shown in millimeters
ORDERING GUIDE

| Model | Temperature Range | Serial Interface Description | Package Description | Package Option | Branding |
| :---: | :---: | :---: | :---: | :---: | :---: |
| AD7879ACBZ-RL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SPI Interface | 12-Ball WLCSP | CB-12-1 | T2Y |
| AD7879ACBZ-500R7 ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SPI Interface | 12-Ball WLCSP | CB-12-1 | T2Y |
| AD7879ACPZ-RL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SPI Interface | 16-Lead LFCSP_VQ | CP-16-10 |  |
| AD7879ACPZ-500R7 ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SPI Interface | 16-Lead LFCSP_VQ | CP-16-10 |  |
| AD7879-1ACBZ-RL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $1^{2} \mathrm{C}$ Interface | 12-Ball WLCSP | CB-12-1 | T0Q |
| AD7879-1ACBZ-500R7 ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $1^{2} \mathrm{C}$ Interface | 12-Ball WLCSP | CB-12-1 | TOQ |
| AD7879-1ACPZ-RL ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $1^{2} \mathrm{C}$ Interface | 16-Lead LFCSP_VQ | CP-16-10 |  |
| AD7879-1ACPZ-500R7 ${ }^{1}$ | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $1^{2} \mathrm{C}$ Interface | 16-Lead LFCSP_VQ | CP-16-10 |  |
| EVAL-AD7879EBZ ${ }^{1}$ |  | SPI Interface | Evaluation Board |  |  |
| EVAL-AD7879-1EBZ ${ }^{1}$ |  | $1^{2} \mathrm{C}$ Interface | Evaluation Board |  |  |

${ }^{1} Z=$ RoHS Compliant Part.
$\square$
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[^0]:    ${ }^{1}$ See the Terminology section.
    ${ }^{2}$ Guaranteed by characterization, not production tested.
    ${ }^{3}$ Sample tested at $25^{\circ} \mathrm{C}$ to ensure compliance.

[^1]:    ${ }^{1}$ Guaranteed by design, not production tested.

[^2]:    ${ }^{1}$ Guaranteed by design, not production tested.

[^3]:    ${ }^{1}$ Transient currents of up to 100 mA do not cause SCR latch-up.

[^4]:    ${ }^{1}$ Do not write to addresses outside the register map.

[^5]:    ${ }^{1}$ If GPIO is enabled, AUX and VBAT are both ignored. If AUX and VBAT are both selected, and GPIO is disabled, AUX is ignored, and VBAT is measured.
    ${ }^{2}$ Note that these settings clear to 00 at the end of the conversion sequence if the conversion interval timer bits in Control Register 1 ( $0 \times 01$ ) Bits 7:0=0x00h at the end of the conversion sequence.

[^6]:    ${ }^{1}$ This delay occurs before conversion of the $X$ and $Y$ coordinate channels (including $Z 1$ and $Z 2$ ) to allow for screen settling and before the first conversion to allow the ADC to power up.

